

<b>Notice of References Cited</b>	Application/Control No. 10/536,817		Applicant(s)/Patent Under Reexamination NOWOTTNICK, JURGEN	
	Examiner NABIL H. SYED		Art Unit 2612	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0164209	07-2006	De Zeeuw, Stephan	340/005.72
	B	US-			
	C	US-			
	D	US-			
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**FOREIGN PATENT DOCUMENTS**

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